Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/890,290	CHENG ET AL.
Examiner	Art Unit
Krishnan S. Menon	1723

SEARCHED				
Class	Subclass	Date	Examiner	
210	321.6 321.61 321.74 - 321.8			
	321.84 to			
	321.89			
	450			
	500.27			
264	41 129			
156	69 187			
	192			
	244.12			
95	54			
96	8,10	6/4/2005	КМ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH N (INCLUDING SEAR)	CH STRATEGY)
	DATE	EXMR
Inventor search and search update for RCE	6/4/2005	КМ
156/293 word search	1/28/2006	КМ
updated	8/3/2006	КМ